

**Search Notes**

Application/Control No.

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Examiner

Patricia L. Hailey

Applicant(s)/Patent under  
Reexamination

FURUKAWA ET AL.

Art Unit

1755

**SEARCHED**

Class	Subclass	Date	Examiner
502	178	2/15/2007	PLH
423	439	2/15/2007	PLH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
502	178	2/15/2007	PLH
423	439	2/15/2007	PLH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
search updated; EAST search.	2/15/2007	PLH